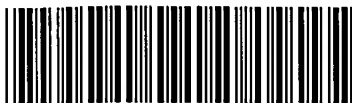


Search Notes

Application/Control No.

10/646,324

Examiner

Trenton J. Roche

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2193

SEARCHED

Class	Subclass	Date	Examiner
717	168-173 (text search)	11/30/2006	TR
714	(text)	12/26/2006	TR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	12/19/2006	TR
Consulted Meng-Ai An Re: Possible Restriction	12/19/2006	TR
IEEE, ACM, CiteSeer search	12/19/2006	TR